g		TEST and OPERATING PROCEDURE		
	<u>GE</u> Industrial Systems	DATE: 06/07/02	PAG	E 1 OF 2
		QUALITY REP	Robert D.	wall
TITLE:	IC3600AVSD TEST PROCEDUE	RF	PROCEDURE:	

1. <u>INTRODUCTORY DESCRIPTION</u>

A. This procedure establishes the methods for testing a .IC3600AVSD Voltage Sensitive Relay.

- B. Environmental ranges: 70 +/- 10 Deg. F. with 20-75% R.H.
- C. Unit warm-up/stabilization period requirement: NONE
- D. Personnel using this procedure are expected to have a high degree of confidence and expertise in related testing and calibration procedures.
- E. Procedures not explained here are considered to be understood as common practice.

2. TEST EQUIPMENT VERIFICATION

- A. Verify the accuracy of the standard(s) used in the repair/calibration process by evidence of recent calibration labeling affixed to the test equipment.
- B. All measurement standards used in this procedure shall be traceable to the NATIONAL INSTITUTE of STANDARDS and TECHNOLOGY (N.I.S.T.) and shall have the accuracy, stability, range and resolution required for the intended use.
- C. Unless otherwise specified, the collective uncertainty of the Measurement Standard(s) shall not exceed twenty five percent of the acceptable tolerance for each characteristic being calibrated.
- D. All deviations shall be documented.

3. EQUIPMENT CLEANING

A. All equipment clean will be performed as instructed in the GEES SOP Sec. 14.0

4. EQUIPMENT INSPECTION

- A. The following criteria should be used as a guideline or basis for the inspection process of the this unit:
 - 1. Wires broken or cracked.
 - 2. Terminal strips / connectors broken or cracked.
 - 3. Loose wires.
 - 4. Components visually damaged.
 - 5. Capacitors leaking.
 - 6. Solder joint, cold.
 - 7. Circuit board discolored or burned.
 - 8. Printed wire runs burned or damaged.

g	GE Industrial Systems	TEST and OPERATING PROCEDURE		
		DATE: 06/07/02		PAGE 2 OF 2
		QUALITY RE	P: Rober	Dwell
TITLE:	IC3600AVSD TEST PROCEDUR	.	PROCED LOU-GE	OURE: D-IC3600AVSD-B

5. <u>REVISION HISTORY</u>

Revision	Date	Initials	Reason for Revision
A	10/4/94	PDK	Initial Procedure – After Verification
В	06/07/02	RKD	Added section 5 & 6, Changed procedure
			number
C			
D			
E			
F			
G			
H			
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K			

g	GE Industrial Systems	TEST and OPERATING PROCEDURE DATE: 06/07/02 PAGE 3 OF 2		
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TITLE	i:		PROCEDURE:	
	IC3600AVSD TEST PROCEDURI	<u> </u>	LOU-GED-IC3600AVSD-B	
6.	REFERENCE DOCUMENT	ATION		
υ.	REFERENCE DOCUMENT	ATION		
	Reference: GEK			
	• Factory Procedure #			
7.	THEORY OF OPERATION A. Refer to the IC3600A		on Bulletin(s) for theory of operation.	
8.	TEST EQUIPMENT TO BE	LICED		
0.			acquisition cards	
	 General Purpose Testing Computer with data acquisition cards. General Purpose Testing Interface 			
	• Personality Module # 1	1		
9.	FINAL TEST AND OPERAT	LIUN DDUCESS		
7.	• Assure that the GPTC a		d and operational	
			g programs from the menu.	
	• Follow the instructions			

TEST WRITTEN BY: Paul Kelley	DATE:	10/4/94	
TEST VERIFIED BY:		DATE:	